



TestConX 한국

Korea

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Suwon, South Korea

Integrated Modeling and Experimental Optimization of a Thermal Management System for NkW Heat dissipation

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SEMICS



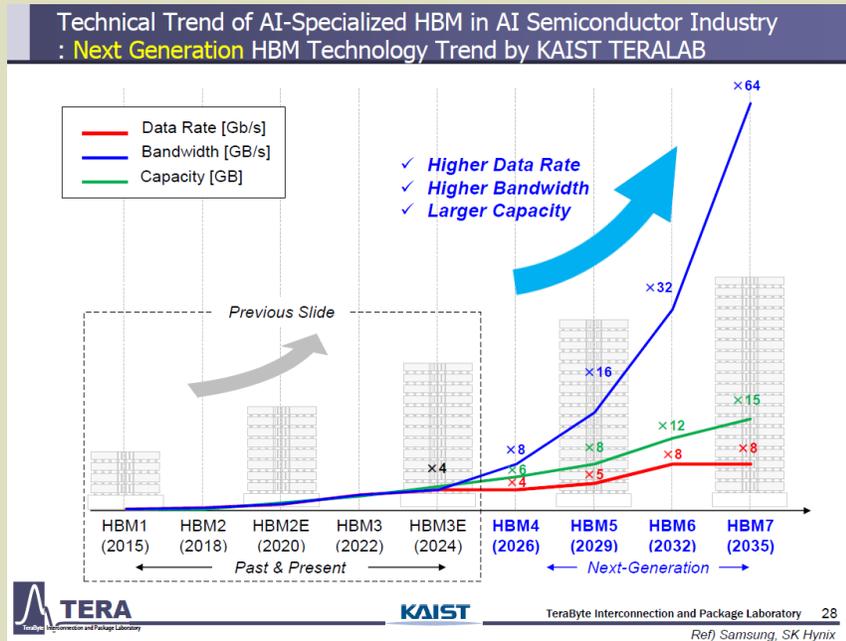
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- Simple theory
- Our Approach
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Thermal Requirements



Next-Generation HBM Roadmap by KAIST TERALAB

Ver 1.2 / updated.250521

	HBM4 (2026)	HBM5 (2029)	HBM6 (2032)	HBM7 (2035)	HBM8 (2038)
Data Rate	8 Gbps	8 Gbps	16 Gbps	24 Gbps	32 Gbps
# of I/O	2,048	4,096	4,096	8,192	16,384
Bandwidth	2.0 TB/s	4 TB/s	8 TB/s	24 TB/s	64 TB/s
Capacity/die	24 Gb	40 Gb	48 Gb	64 Gb	80 Gb
# of die stack	12/16-Hi	16-Hi	16/20-Hi	20/24-Hi	20/24-Hi
Capacity /HBM	36/48 GB	80 GB	96/120 GB	160/192 GB	200/240 GB
Power/HBM	75 W	100 W	120 W	160 W	180 W
Die stacking	Microbump (MR-MUF)		Bump-less Cu-Cu Direct bonding		
Cooling Method	Direct-to-Chip (D2C) Liquid Cooling	Immersion Cooling		Embedded Cooling	
HBM Architecture	Custom HBM Base Die HBM-LPDDR	3D NMC-HBM & stacked cache / decap	Multi-tower HBM Active / Hybrid Interposer	Hybrid HBM Architecture HBM-HBF HBM-3D LPDDR	Full-3D / HBM Centric Computing Architecture
Additional Features (Patent)	NMC processor + LPDDR Ctrl	+ Cache + CXL + on-die/stacked decap + HBM shielding	+ Network switch + Bridge die + Asymmetric TSV	+ HBF/LPDDR Ctrl + Storage network	+ HBM Centric Interposer + Double side Cooling + Edge-expand Stack
AI Design Agent	ubump & TSV-array Decap placement Optimization	I/O Interface Optimization considering PSIJ	Hybrid Equalizer + Generative AI based SI/PI Metric Estimation	LLM based Human Interactive AI Design Agent	

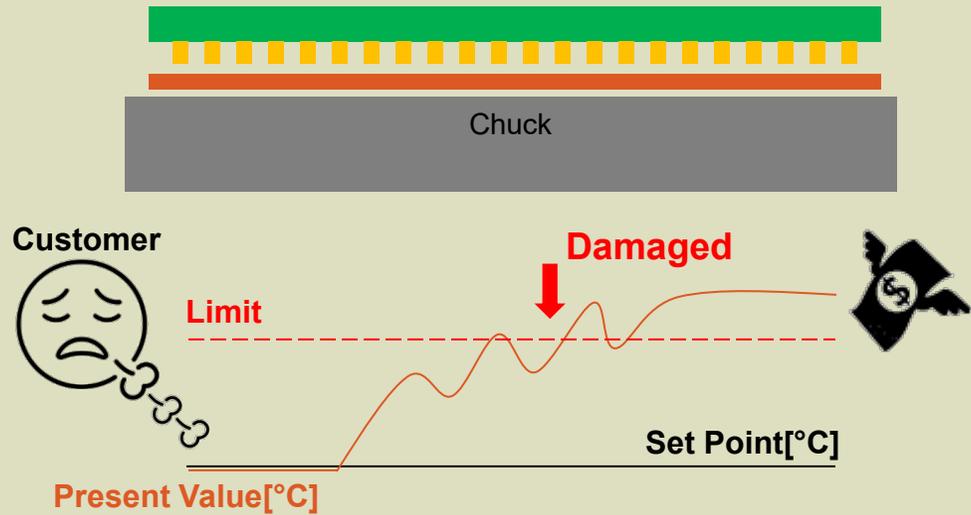
Legend:
 - HBM Spec. (Grey)
 - Packaging/Cooling (Light Blue)
 - Architecture (Light Green)
 - AI Design Agent (Light Purple)

Source : HBM Roadmap Ver1.7 Workshop by KAIST TERALAB (2025)

- The rapid expansion of the AI market is pushing HBM requirements to new levels
 - Bandwidth nearly doubles every 2~3 years
- **Driving a sharp rise in NkW(per shot) Heat dissipation requirements in the Prober Market**

Customer's Requirements

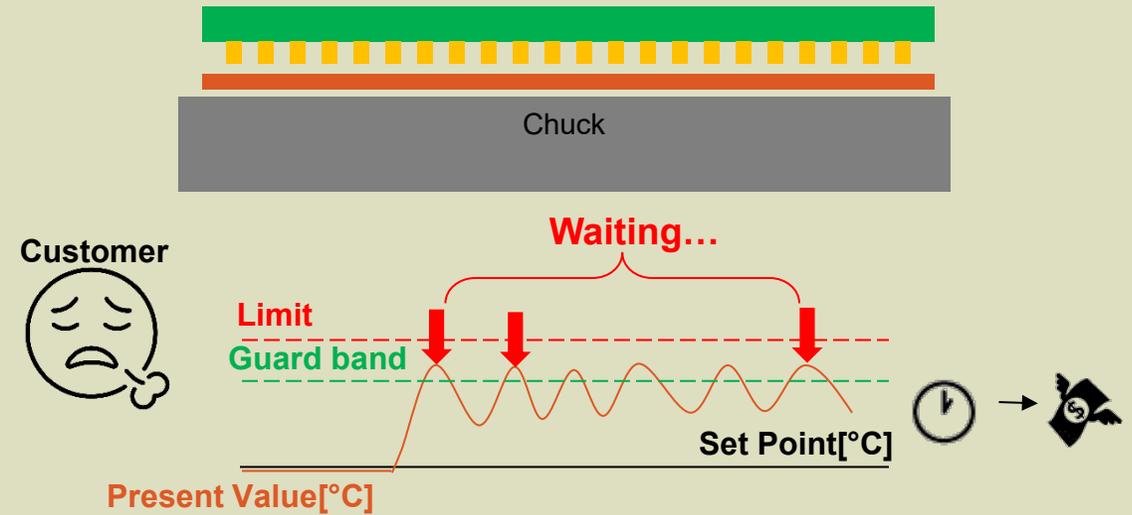
Thermal interlock X



Probe card damaged → Wafer damaged

→ X ↑↑↑↑↑↑↑↑↑↑

Thermal interlock O

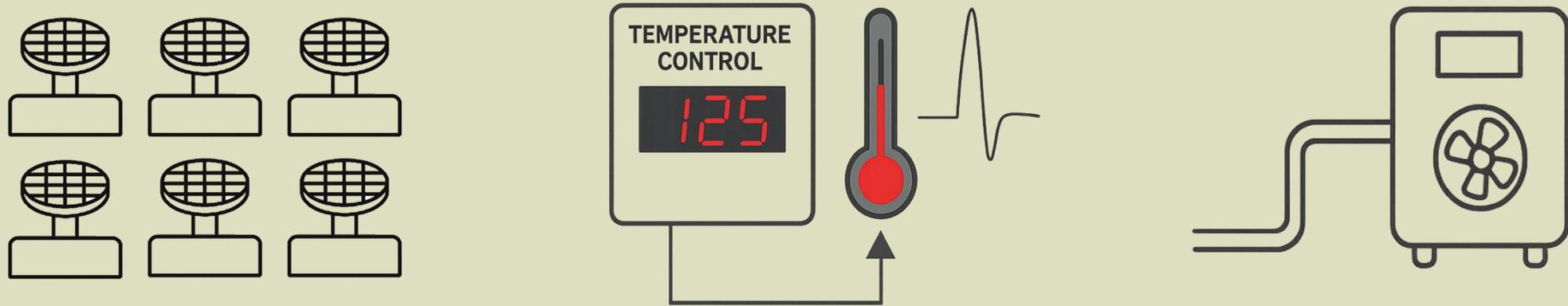


Waiting for PV within Guard band

→ X ↑↑↑↑

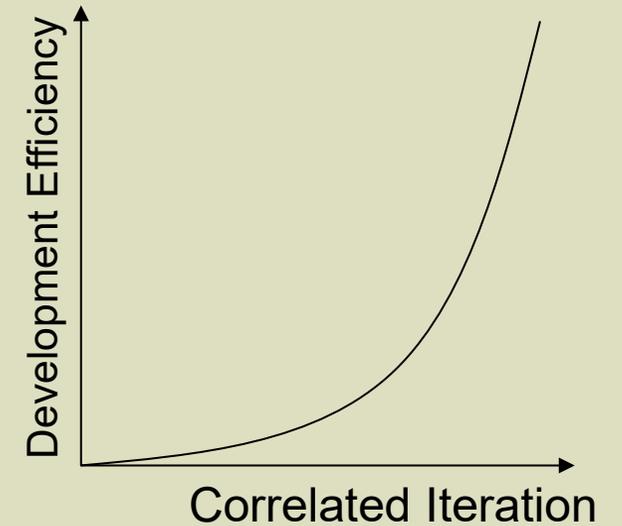
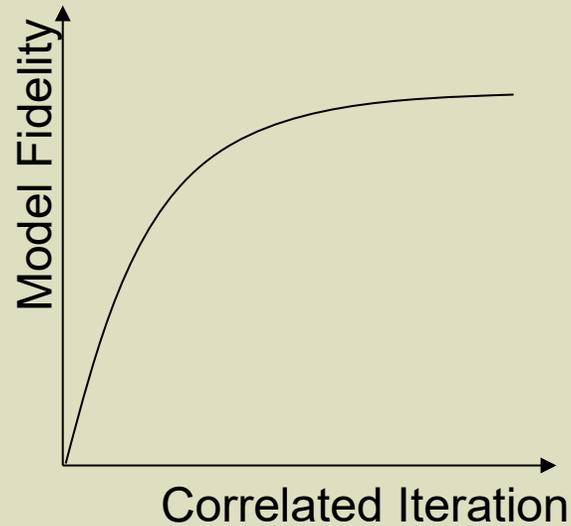
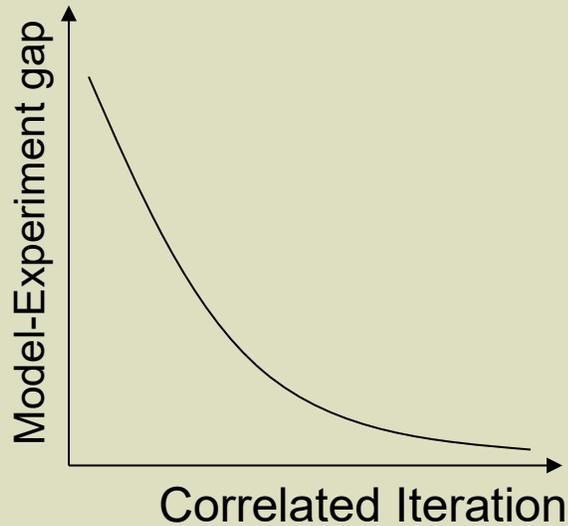
No more Waste!!!

Development Challenge for Prober



- **Chuck** : Rapid development of high-uniformity thermal chuck design, suitable for dissipation...
- **Chiller** : Optimizing Capacity, Multi-channel cooling, Rapid transient response...
- **Control system** : Capable of responding precisely and stably to various Thermal loads...
- **System Optimization & Stabilization**
: Ensuring robustness and reliability under accelerated development cycles...

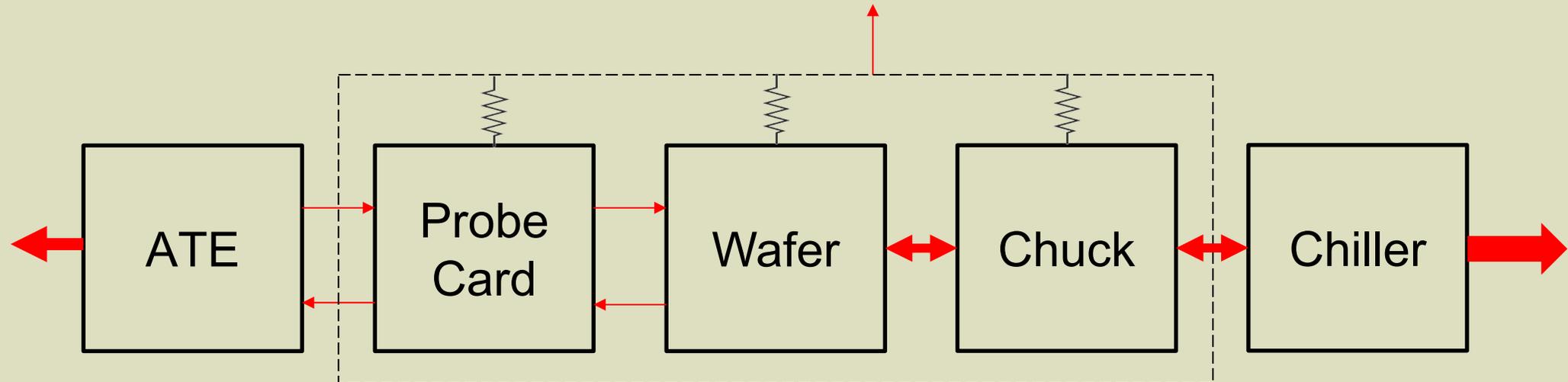
Strategy = Correlation



- “Correlation” : The Iterative Feedback loop between model and experiment
- The Correlation is the driver of accelerated development

Heat dissipation schematics for NkW

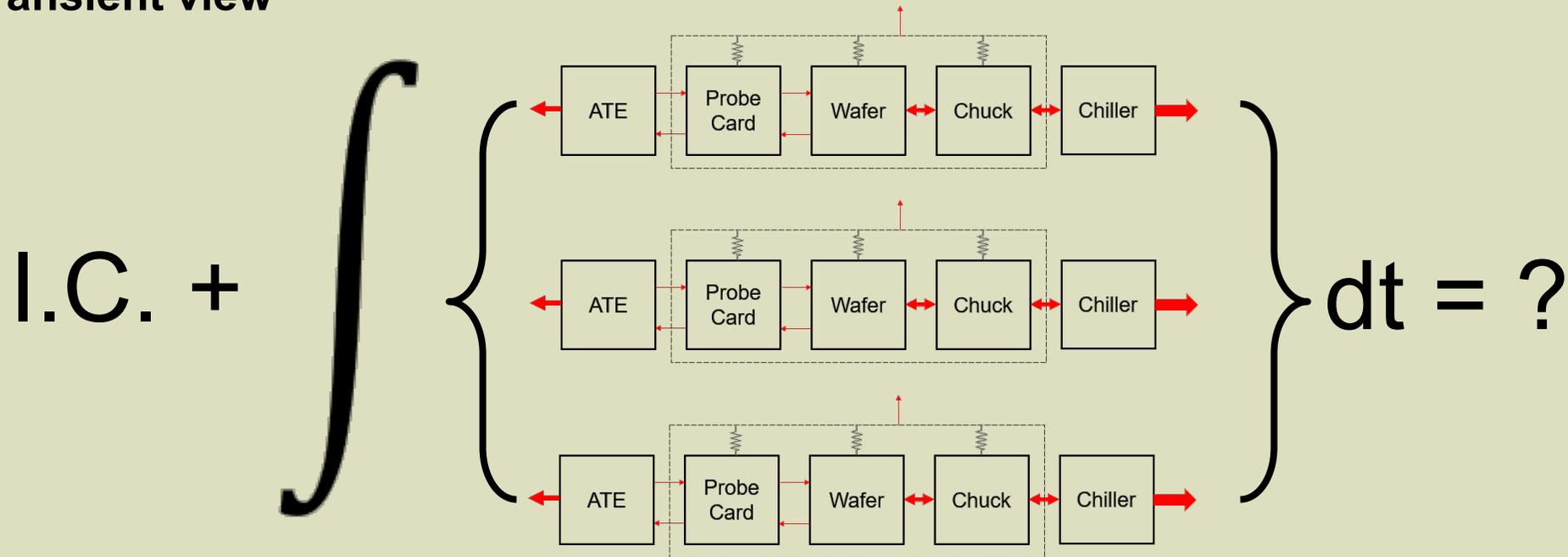
Steady-state view



- Steady-state energy flow perspective
: Considering whether the system has reached thermal equilibrium (no change)

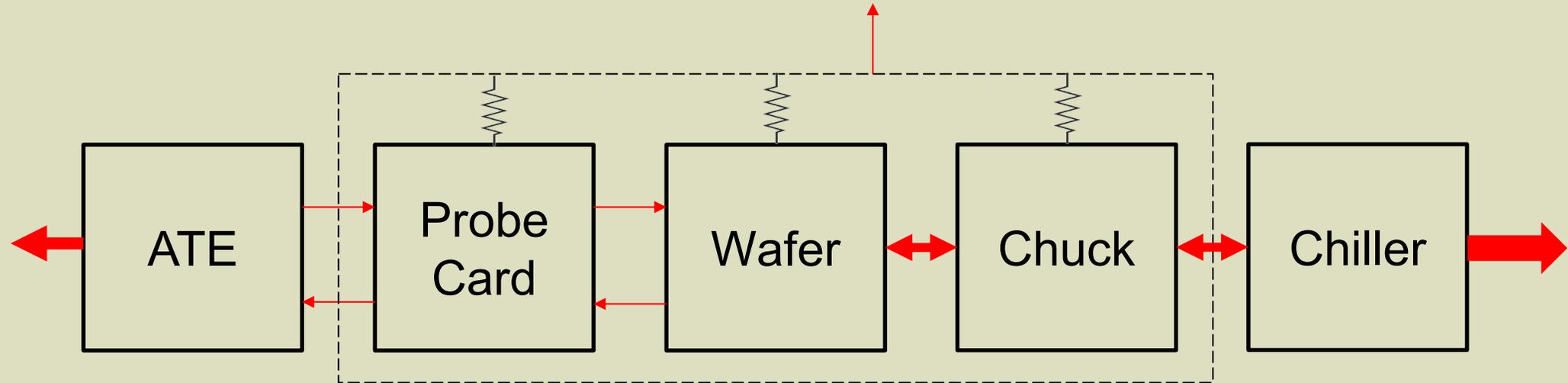
Heat dissipation schematics for NkW

Transient view



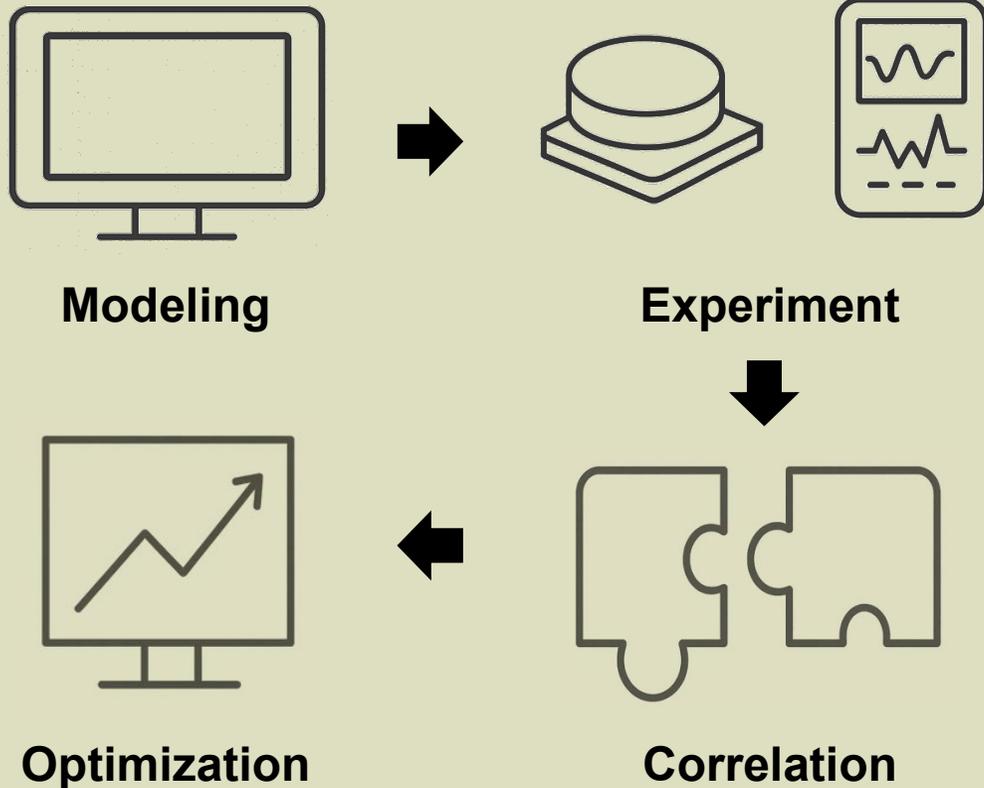
- Transient temperature control perspective
: Considering how cumulative effects of energy flows over time result in the temperature response of each part

Heat dissipation schematics for NkW



- Wafer side heat load is irregular and unpredictable disturbance to Chuck temperature control system
- A good NkW class heat dissipation system has,
 - **High heat dissipation capacity**
 - **Rapid recovery to SP**
 - **Overshoot/Undershoot must be minimized**
 - **Robust control under various heat loads**

Development cycle



- Modeling

- Modeling provides initial direction before experiments
- Reduces trial and error in early stage
- Establishes baseline expectations for performance

- Experiment

- Verification of actual performance under real conditions
- Ensures repeatability and reliability of results
- Identifies unexpected factors in real operation

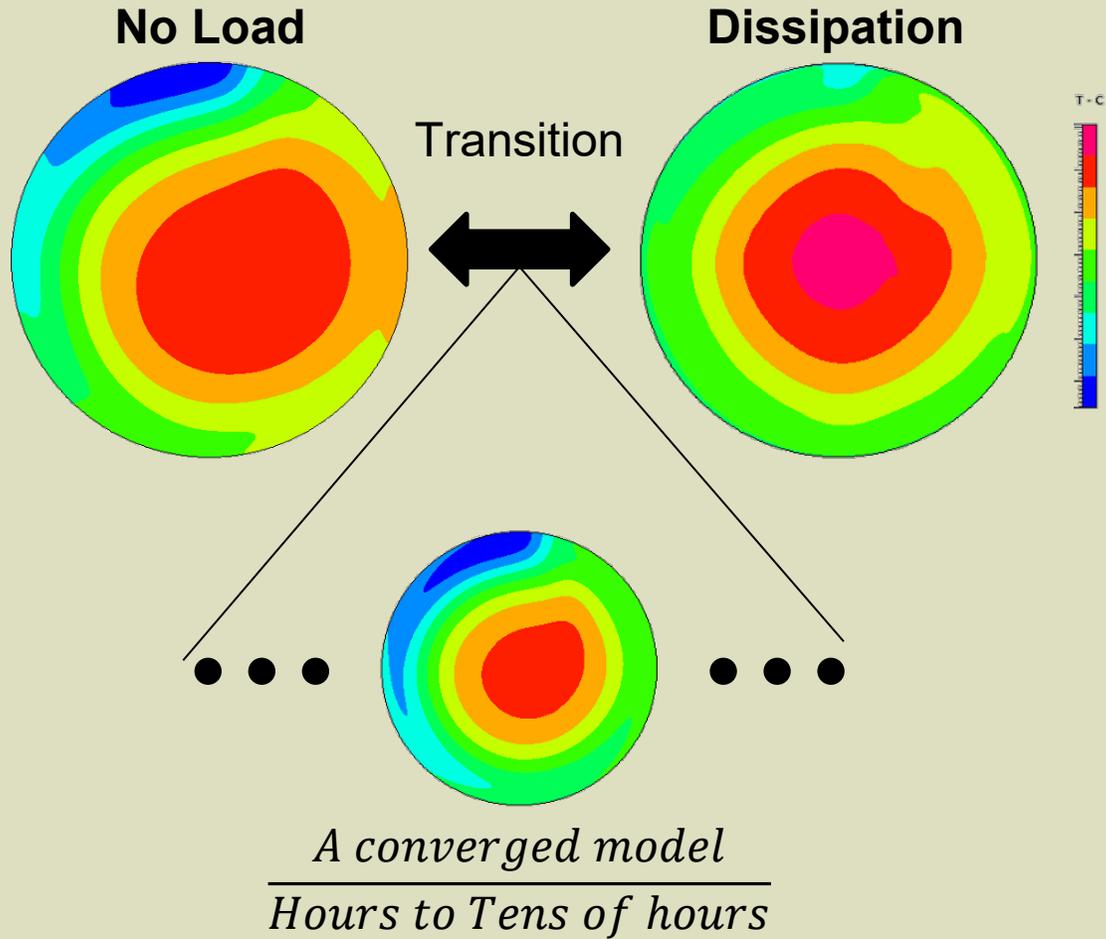
- Correlation

- Validation of model to experiment correlation
- Key factor for accelerating the development cycle

- Optimization

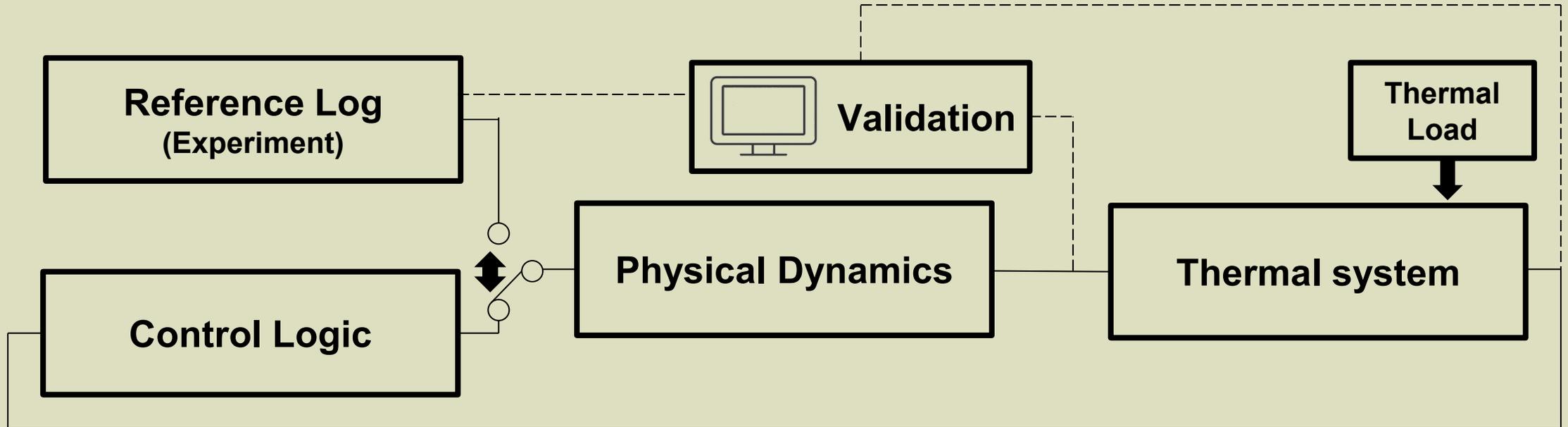
- Performance improvement
- System simplification

Computational Fluid Dynamics (CFD) Modeling



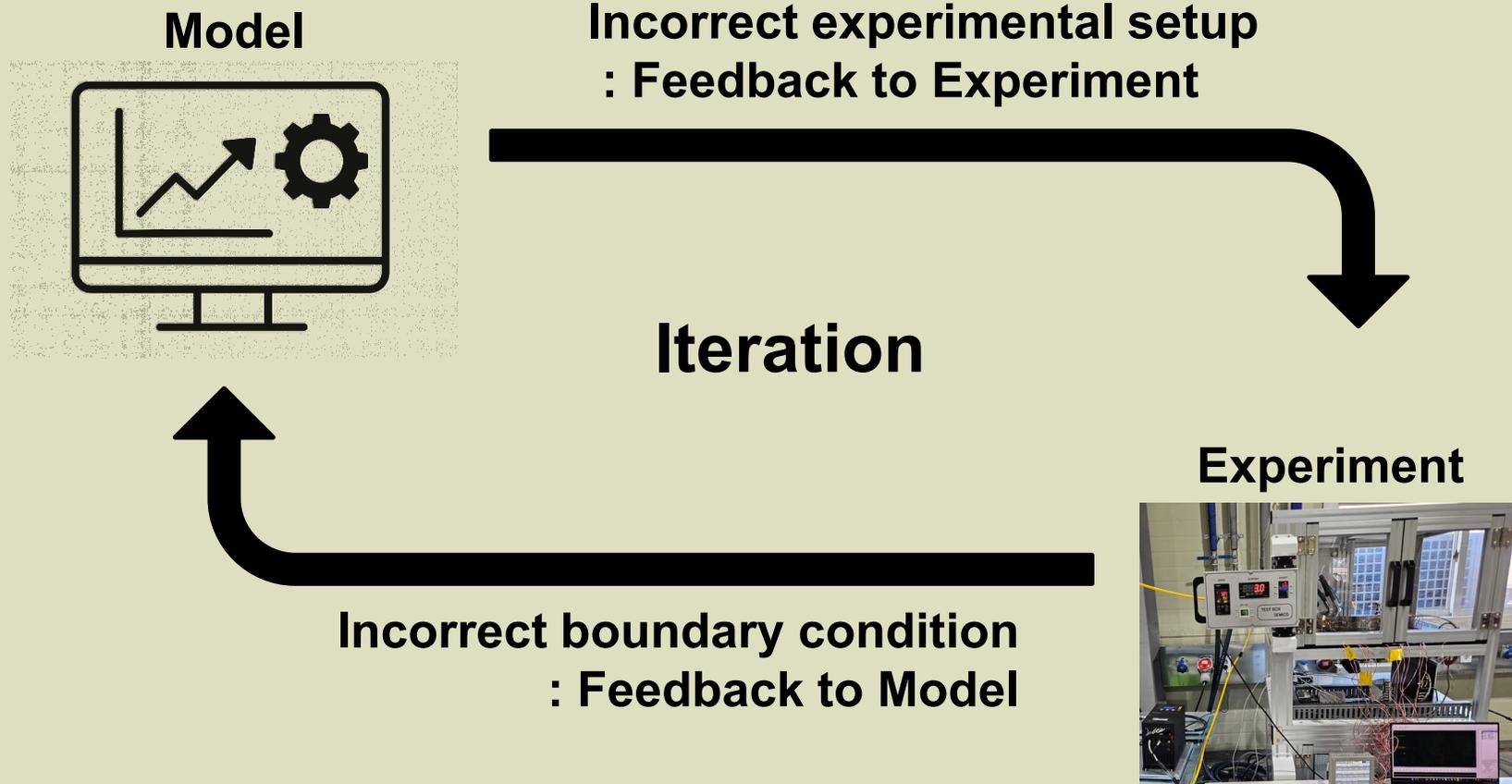
- **Steady-State Analysis**
 - High-level correlation with experiments can be achieved based on extensive past data
- **CFD Limits**
 - Transient CFD requires hours to tens of hours per each step (Full result -> Few months...)
- **Our Approach**
 - Use steady-state results for reliable baseline
 - Predict transient behavior from intermediate simulation outputs and validate through experiments
 - Control dynamics cannot be fully assessed by CFD alone
 - System level modeling is required

System level modeling



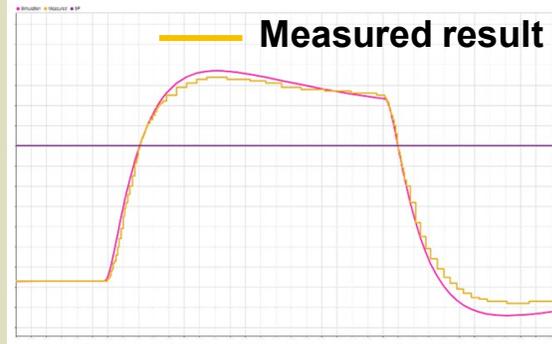
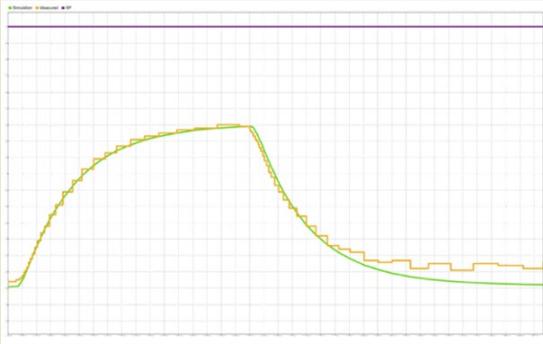
- CFD based steady-state analysis provides a high-fidelity baseline
- Transient dynamics are complemented through System-level modeling and experimental validation
- This integrated approach enables quantitative analysis, control tuning and optimization strategy development

Correlation

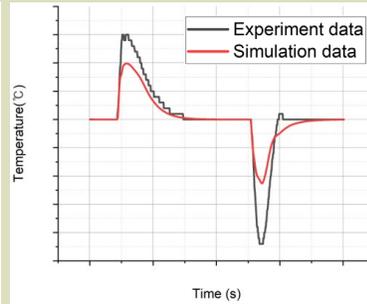
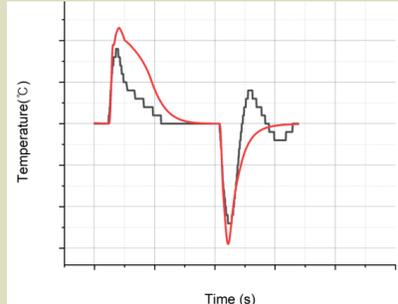
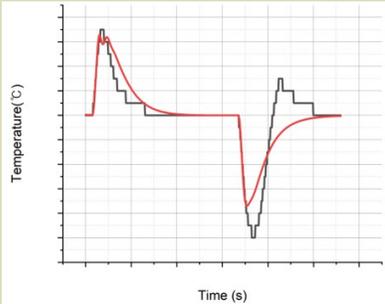


Correlation

Open Loop Validation



Closed Loop Validation

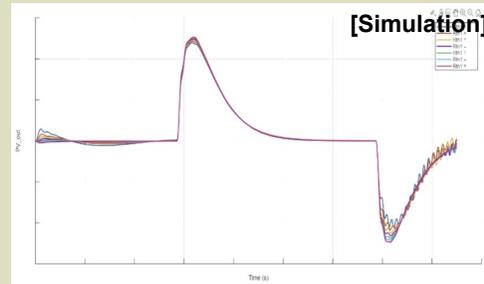


- **Validation Path**
 - Open-loop → Closed-loop validation
 - Verify the matching accuracy while gradually increasing the number of control points
- **Key Challenges**
 - Coolant property variation depends on T
 - Lumped model
 - Heat exchange efficiency becomes critical
 - Dimension reduction → Fidelity limits
- **Fidelity vs. Speed**
 - Trade-off between fidelity and speed
 - Finding the optimum by complementing with experiments

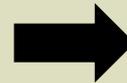
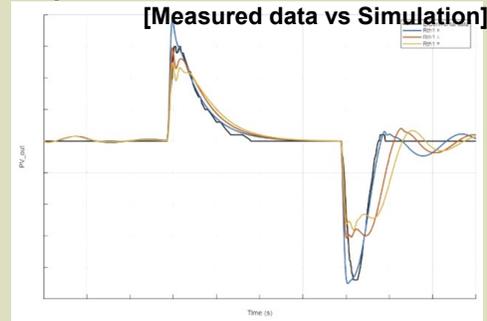
Correlation

Parameter sweep

A parameter



B parameter

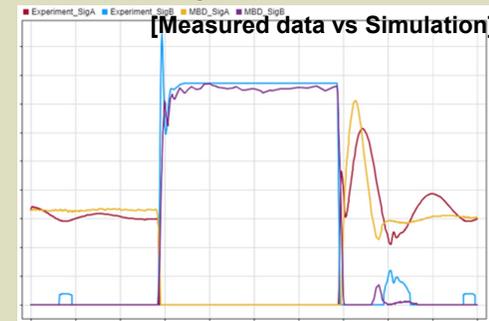


4kW Thermal Load

Temperature

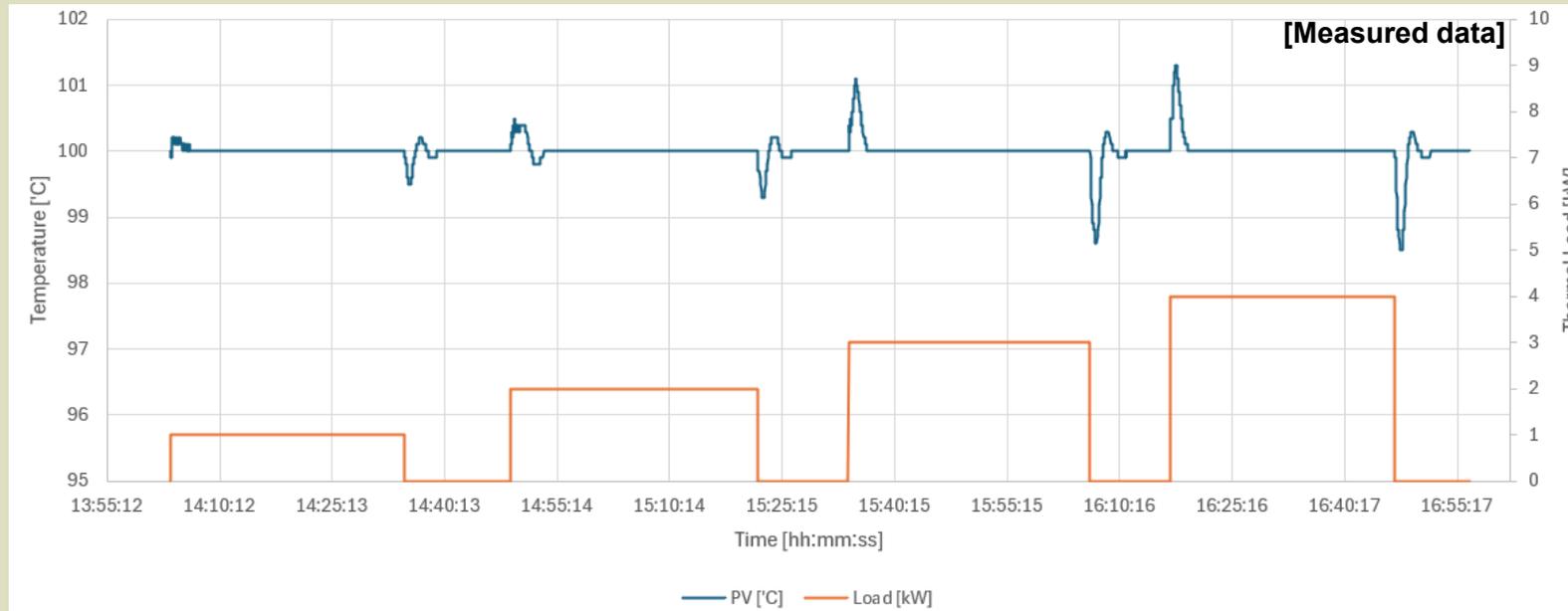


Control Output



- Parameter sweep quantifies the impact of key parameters on performance
- Automation of parameter sweep accelerates model refinement
- Enables modeling with high similarity to experimental results

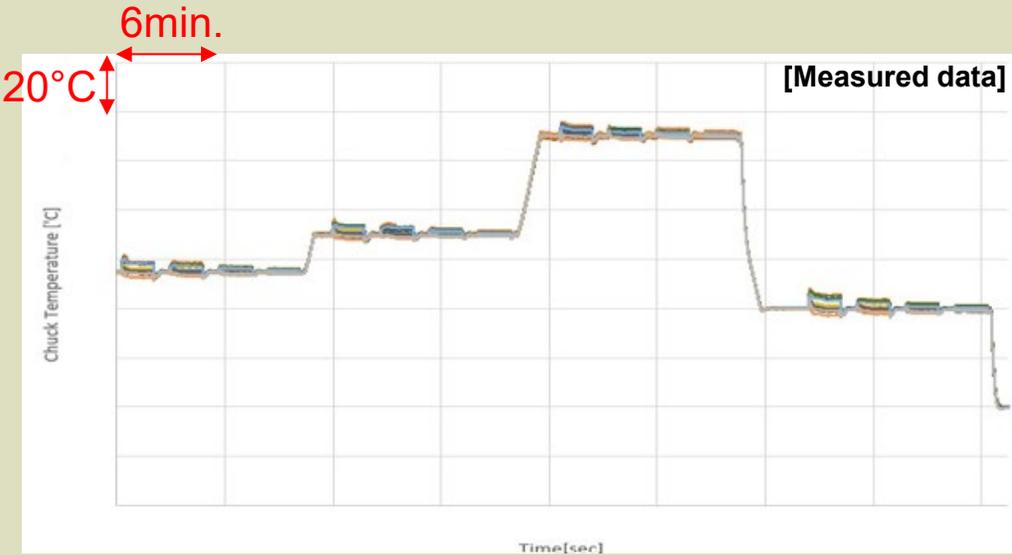
4kW Heat dissipation system



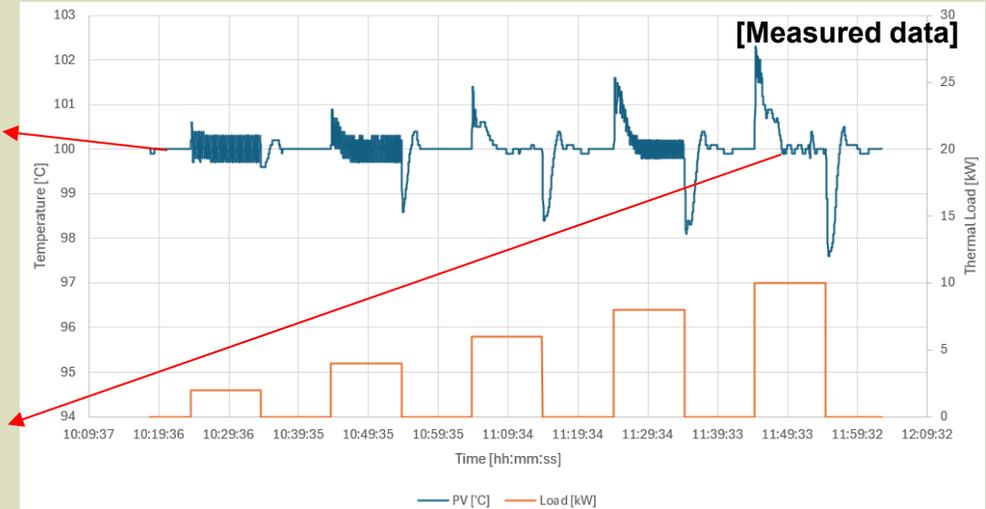
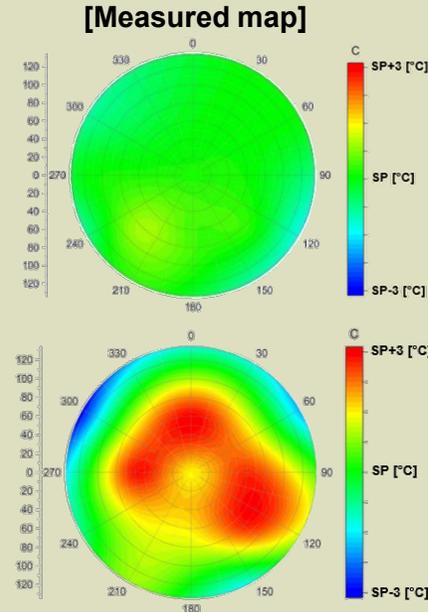
Chuck PV under 1~4kW from Wafer-side(12inch) load

- At 4kW Sudden Load (80~125°C),
 - Overshoot / Undershoot <math>< 1.5^{\circ}\text{C}</math>
 - Recovery to SP <math>< 3\text{min}</math>.
 - Recovery within guard band($\pm 1^{\circ}\text{C}</math>) <math>< 1\text{min}</math>.$
- **The solution has already been successfully applied in the field**

10kW Heat dissipation system



Chuck PV (21points)
under 8, 6, 4, 2kW from Wafer-side(12inch) load



Chuck PV
under 2, 4, 6, 8, 10kW from Wafer-side(12inch) load

- At 10kW Sudden Load (80~150°C)
 - Overshoot / Undershoot < 2.5°C
 - Recovery to SP < 5min.
 - Recovery within guard band($\pm 1^\circ\text{C}$) < 1.5min.
- Ongoing control logic optimization to ensure stable control under various heat loads

Closing

- Rapid scale-up achieved through Correlation from 4kW to 10kW
- We welcome the double-digit kW dissipation challenge

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